

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/000,262	BEZEK ET AL.	
	Examiner	Art Unit	Page 1 of 1
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5076433	12-1991	Howes	206/459
	B	US-6068865	05-2000	Lee et al	426/43
	C	US-64744494	11-2002	Miller	220/379
	D	US-6070752	06-2000	Nava et al	220/521
	E	US-6299014	10-2001	Nava et al	220/521
	F	US-4794008	12-1988	Schmidt et al	426/234
	G	US-D 452823	01-2002	Bezek et al	D9/502
	H	US-6311860	11-2001	Reidinger et al	220/521
	I	US-5180079	01-1993	Jeng	220/705
	J	US-6472007	10-2002	Bezek et al	426/115
	K	US-5987913	11-1999	Andrzejczak	62/457.2
	L	US-5310072	05-1994	Matusovsky et al	220/23.83
	M	US-6596328	07-2003	Bezek et al	426/115]\

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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